Search Notes			

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/722,218	CHENG ET AL.	
Examiner	Art Unit	
Phat X. Cao	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	357	3/30/2007	PC
257	365	3/30/2007	PC
257	371	3/30/2007	PC
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST: IS&R (updated search)	3/30/2007	PC
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